Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/551,143	YOSHIDA ET AL.
Examiner	Art Unit

Kelly L. Jerabek

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SEARCHED					
Class	Subclass	Date	Examiner		
348	266	6/6/2006	КЈ		
	272-274				
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257	440				
358	515-517				
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INTERFERENCE SEARCHED				
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IEEE	6/6/2006	КJ
EAST Keyword	6/6/2006	
Yin Le	4/26/2005	
Ngoc Yen Vu	10/5/2005	